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FGPF7N60LSD 600V, 7A Low Saturation IGBT CO-PAK

Features

- Low saturation voltage : $V_{CE(sat)}$ = 1.4 V @ I_C = 7A
- · High input impedance
- CO-PAK, IGBT with FRD : t_{rr} = 50 ns (typ.)

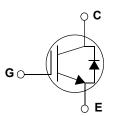
Description

Fairchild's Insulated Gate Bipolar Transistors (IGBTs) provides very low conduction and switching losses. The device is designed for Lamp applications where very low On-Voltage Drop is a required feature.

Applications

Lamp applications (Hallogen Dimmer)





Absolute Maximum Ratings

Symbol	Description		FGPF7N60LSD	Units
V _{CES}	Collector-Emitter Voltage		600	V
V _{GES}	Gate-Emitter Voltage		± 20	V
I _C	Collector Current @ T _C = 25°C		14	Α
	Collector Current	@ T _C = 100°C	7	А
I _{CM (1)}	Pulsed Collector Current		21	А
lf	Diode Continous Forward Current	@ T _C = 100°C	12	Α
I FM	Diode Maximum Forward Current		60	Α
P _D	Maximum Power Dissipation	@ T _C = 25°C	45	W
	Maximum Power Dissipation	@ T _C = 100°C	18	W
T _J	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
T _L	Maximum Lead Temp. for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

Notes :

(1) Repetitive rating : Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Units
R _θ JC (IGBT)	Thermal Resistance, Junction-to-Case		2.8	°C/W
$R_{\theta JC}(DIODE)$	Thermal Resistance, Junction-to-Case		4.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (PCB Mount) (2)		62.5	°C/W

Notes :

(2) Mounted on 1" squre PCB (FR4 or G-10 Material)

Package Marking and Ordering Information

Device Marking	Device	Package	Packaging	Qty per Tube	Max Qty	
Device Marking	Device	Fackage	Type	Qty per rube	per Box	
FGPF7N60LSD	FGPF7N60LSDTU	TO-220F	Rail /Tube	50ea	1,000ea	

Electrical Characteristics of the IGBT $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charact	eristics					
BV _{CES}	Collector-Emitter Breakdown Voltage	V _{GE} = 0V, I _C = 250uA	600			V
ΔB _{VCES} / ΔΤ _J	Temperature Coefficient of Breakdown] Voltage	V _{GE} = 0V, I _C = 1mA		0.6		V/°C
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0V$			250	uA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0V$			± 100	nA
On Charact	eristics					
V _{GE(th)}	G-E Threshold Voltage	$I_C = 7mA$, $V_{CE} = V_{GE}$	5.0	6.5	8.0	V
V _{CE(sat)}	Collector to Emitter	I _C = 7A, V _{GE} = 15V		1.4	2.0	V
-()	Saturation Voltage	I _C = 7A, V _{GE} = 15V, T _C = 125°C		1.47		V
		I _C = 14 A, V _{GE} = 15V		1.85		V
D		1 5 . 01				
C _{ies}	Input Capacitance	V _{CE} = 30V _, V _{GE} = 0V,		510		pF
C _{oes}	Output Capacitance	f = 1MHz		55		pF
C _{res}	Reverse Transfer Capacitance	=		15		pF
	Characteristics Turn-On Delay Time			120		ns
t _{d(on)}	Turn-On Delay Time			120		ns
t _r	Rise Time			44	-	ns
t _{d(off)}	Turn-Off Delay Time	V - 300 V I - 70		410	535	ns
t _f	Fall Time	$V_{CC} = 300 \text{ V, } I_{C} = 7\text{A,}$ $R_{G} = 470\Omega, V_{GE} = 15\text{V,}$		2320	3480	ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 25°C		0.27		uJ
E _{off}	Turn-Off Switching Loss			3.8		mJ
E _{ts}	Total Switching Loss			4.07	6.1	mJ
t _{d(on)}	Turn-On Delay Time			105		ns
t _r	Rise Time			50		ns
t _{d(off)}	Turn-Off Delay Time			420		ns
t _f	Fall Time	$V_{CC} = 300 \text{ V}, I_{C} = 7 \text{ A},$ $R_{G} = 470\Omega, V_{GE} = 15\text{V},$		3745		ns
E _{on}	Turn-On Switching Loss	Inductive Load, T _C = 125°C		0.22		uJ
E _{off}	Turn-Off Switching Loss	\dashv		5.94		mJ
E _{ts}	Total Switching Loss			6.16		mJ
Q _g	Total Gate Charge			24	36	nC
Q _{ge}	Gate-Emitter Charge	$V_{CE} = 300 \text{ V, } I_{C} = 7\text{A,}$		4	6	nC
Q _{gc}	Gate-Collector Charge	── V _{GE} = 15V		10	15	nC
	+	1	1	7.5	1	nH

Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Units
V _{FM}	Diode Forward Voltage		T _C = 25°C		1.65	2.1	V
		I _F = 7A	T _C = 100°C		1.58		
t _{rr}	Diode Reverse Recovery Time		T _C = 25°C		50	65	ns
			T _C = 100°C		58		
Irr	Diode Peak Reverse Recovery Current	I _F = 7A	T _C = 25°C		2.5	3.75	Α
		dI/dt = 200 A/μs	T _C = 100°C		3.3		
Q _{rr}	Diode Reverse Recovery Charge		T _C = 25°C		62.5	122	nC
1			T _C = 100°C		95.7		

Typical Performance Characteristics

Figure 1. Typical Output Characteristics

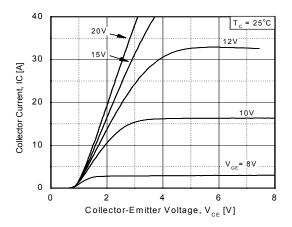


Figure 3. Typical Saturation Voltage Characteristics

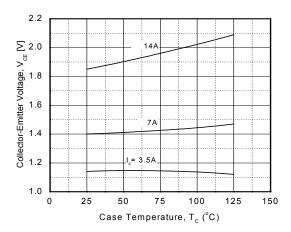


Figure 5. Saturation Voltage vs. Vge

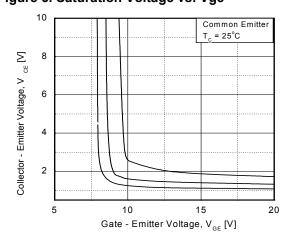


Figure 2. Typical Saturation Voltage Characteristics

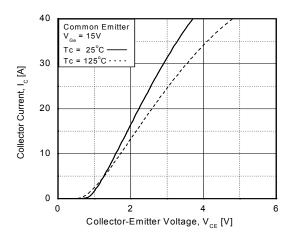


Figure 4. Load Current vs Frequency

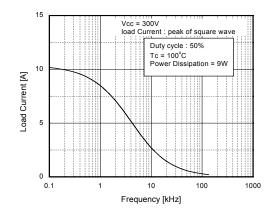
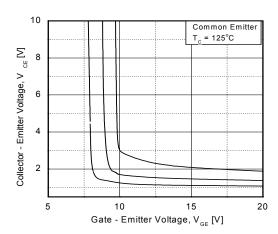


Figure 6. Saturation Voltage vs. Vge



Typical Performance Characteristics (Continued)

Figure 7. Capacitance Characteristics

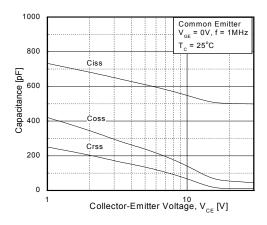


Figure 9. Turn-Off Characteristics vs.
Gate Resistance

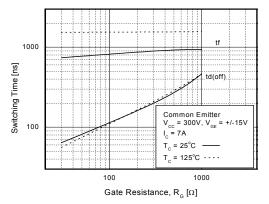


Figure 11. Turn-On Characteristics vs. Collector Current

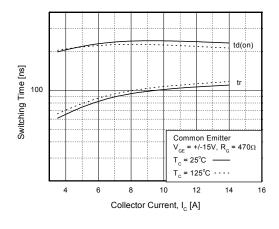


Figure 8. Turn-On Characteristics vs. Gate Resistance

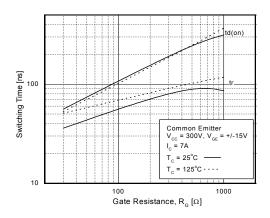


Figure 10. Switching Loss vs. Gate Resistance

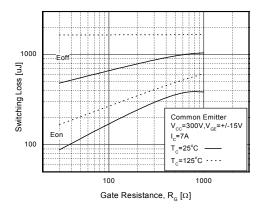
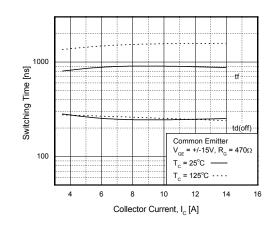


Figure 12. Turn-Off Characteristics vs.
Collector Current



Typical Performance Characteristics (Continued)

Figure 13. Switching Loss vs. Collector Current

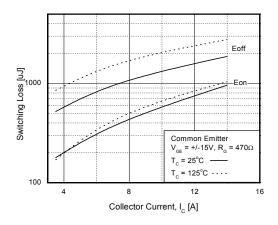


Figure 14. Gate Charge Characteristics

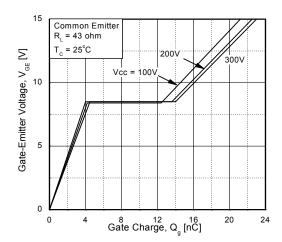


Figure 15. SOA Characteristics

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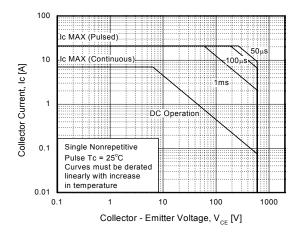
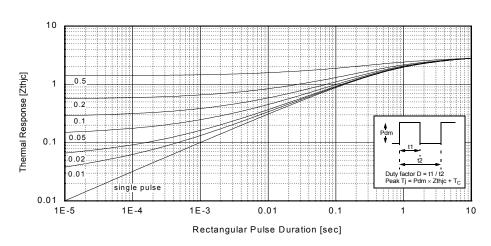


Figure 16. Transient Thermal Impedance of IGBT



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Typical Performance Characteristics (Continued)

Figure 17. Forward Voltage Characteristics

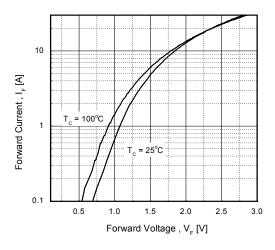


Figure 19. Stored Charge

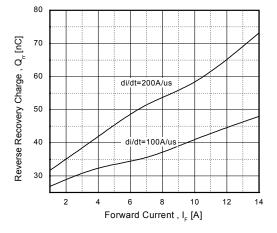


Figure 18. Reverse Recovery Current

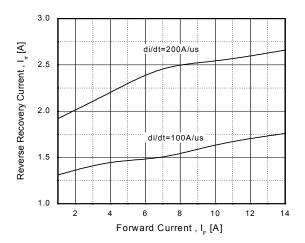
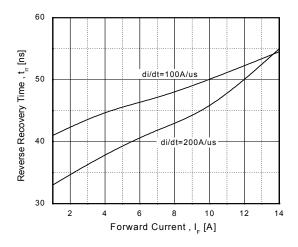


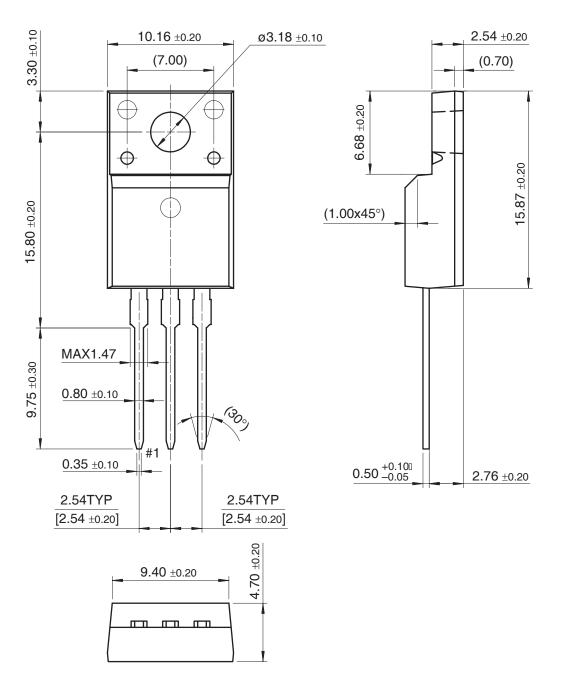
Figure 20. Reverse Recovery Time



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Mechanical Dimensions

TO-220F



Dimensions in Millimeters

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